

MC4300/MC4000 Series

The MTTL complex functions are designed for digital applications in the medium to high-speed range.

These MTTL devices provide significant reduction in package count and increased logic per function over devices in the basic MTTL and MDTL families.

FUNCTIONS AND CHARACTERISTICS (V_{CC} = 5.0 V, T_A = 25° C)

All devices shown can be used with all MTTL and MDTL devices; however, the loading factors shown reflect use with other devices in the same MC-number series unless otherwise noted.

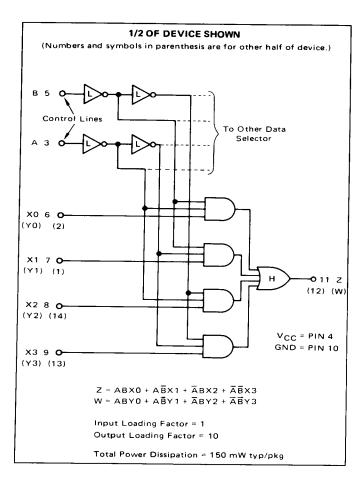
	Operating Temp	perature Range	Output Loading	Propagation Delay	Power Dissipation
Function	Type 1 55 to +125 ⁰ C	Type 1 0 to +75 ⁰ C	Factor Each Output	tpd ns typ	PD mW typ/pkg
Dual 4-Channel Data Selector	MC4300F,L	ИC4000F,L,P	10	Control Line = 18 Data Line = 11	150
BCD-to-Binary/Binary-to-BCD Number Converter		MC4001F,L,P	Open Collector I _{OL} = 16 mA	Address Time <45 ns	300
Dual Data Distributor	MC4302F,L	MC4002F,L,P	10	10.5	175
16 Bit Scratch Pad Memory Cell	MC4304F,L	MC4004F,L,P	10L = 40 mA	Write mode 25 Sense mode 15	250
	<u> </u>		Open Collector		
16 Bit scratch Pad Memory Cell	MC4305F'L	MC4005F,L,P) _{IOL} = 20 mA	Write mode 25 Sense mode 15	250
Binary to One-of-Eight Line Decoder	MC4306F,L	MC4006F,L,P	10	14	100
Dual Binary to One-of-Four Line Decoder	MC4307F,L	MC4007F,L,P	10	14	125
8-Bit Parity Tree	MC4308F,L	MC4008F,L,P	10	15 to 30	150
Dual 4 Bit Parity Tree	MC4310F,L	MC4010F,L,P	10	9.5 to 22	125
4-Bit Shift Register	MC4312F,L	MC4012F,L,P	10	22/bit	180
Quad Type D Flip Flop	MC4315F,L	MC4015F,L,P	10	16	190
Programmable Module-N Decade Counter	MC4316F,L	MC4016F,L,P	8	Clock to Q3 = 50 Clock to Bus = 35	250
Programmable Modulo 2, Modulo 5 Counters	MC4317F,L	MC4017F,L,P	8	Clock to Q3 = 50 Clock to Bus = 35	250
Programmable Module-N Hexadecimal Counter	MC4318F,L	MC4018F,L,P	8	Clock to Q3 = 50 Clock to Bus = 35	250
Dual Programmable Modulo 4 Counters	MC4319F,L	MC4019F,L,P	8	Clock to Q3 = 50 Clock to Bus = 35	250

MC4300/4000 Series continued

			Output Loading	Propagation Delay	Power Dissipation
Function	–55 to +125 ⁰ C	0 to +75 ⁰ C	Factor Each Output	^t pd ns typ	PD mW typ/pkg
Dual 4-Bit Comparator (Open Collector)	MC4321F,L	MC4021F,L,P	10	20	250
Dual 4-Bit Comparator	MC4322F,L	MC4022F,L,P	10	20	250
4-Bit Universal Counter	MC4323F,L	MC4023F,L,P	10	16/bit	200
Dual Voltage Controlled Multivibrator	MC4324F,L	MC4024F,L,P	7	f _{max} = 30 MHz	150
Full Adder	MC4326F,L	MC4026F,L,P	15/12**	25/13#	90
Full Adder	MC4327F,L	MC4027F,L,P	7/6**	25/13#	90
Adder (Dependent Carry)	MC4328F,L	MC4028F,L,P	15/12**	25/13#	125
Adder (Dependent Carry)	MC4329F,L	MC4029F,L,P	7/6**	25/13#	125
Adder (Independent Carry)	MC4330F,L	MC4030F,L,P	15/12**	25/13#	125
Adder (Independent Carry)	MC4331F,L	MC4031F,L,P	7/6**	25/13#	125
Carry Decoder	MC4332F,L	MC4032F,L,P	_	∆t _{pd} = 4 decoder	20
Quad Latch (Open Collector)	MC4335F,L	MC4035F,L,P	7	25	140
Quad Latch	MC4337F,L	MC4037F,L,P	10	25	150
Inverting/Non-Inverting One-of-Eight Decoder	-	MC4038F,L,P	\ \	1	240
Seven Segment Character Generator	_	MC4039F,L,P	Open Collector	Address	240
Binary to Two-of-Eight Decoder	_	MC4040F,L,P	I _{OL} = 20 mA	Time	200
Single-Error Hamming Code Detector and Generator	-	MC4041F,L,P)	<45 ns	240
Quad Predriver	MC4342F,L	MC4042F,L,P	I _{OL} = 50 mA Open Collector	15	120
Dual Line Selector	MC4343F,L	MC4043F,L,P	OL = 400 mA Pulsed	20	70
Phase-Frequency Detector	MC4344F,L	MC4044F,L,P	10	9.0	85
Non-Inverting One-of-Eight Decoder	-	MC4048F,L,P	Open Collector I _{OL} = 16 mA	Address Time <50 ns)	240
Counter-Latch-Decoder	MC4350F,L	MC4050F.L.P	Open Collector I _{OL} = 40 mA	f _{Tog} = 35 MHz	450
Counter-Latch-Decoder	MC4351F,L	MC4051F,L,P	Open Emitter 40 mA Sourcing Capability @ 10% Duty Cycle	f _{Tog} = 35 MHz	450
Dual Decade Counter	MC4352F,L	MC4052F,L,P	10	f _{Tog} = 40 MHz	350
Dual Hexadecimal Counter	MC4353F,L	MC4053F,L,P	10	f _{Tog} = 40 MHz	350
Dual Decade Up/Down Counter	MC4354F,L	MC4054F,L,P	10	f _{Tog} = 12 MHz	600
Dual Binary Up/Down Counter	MC4355F,L	MC4055F,L,P	10	^f Tog = 12 MHz	600
NBCD Adder	MC4356F,L	MC4056F,L,P	10	30	300
Nines Complement/Zero Element	MC4358F,L	MC4058F,L,P	10	30	200
Bus Transfer Switch	MC4360F,L	MC4060F,L,P	10	25	350
Dual Majority Logic Gate	MC4362F,L	MC4062F,L,P	10	Z = 20 Z = 11	75
64-Bit Random Access Memory	-	MC4064F,L,P	Open Collector I _{OL} = 15 mA	Access Time <60 ns	384
Dual MOS-to-TTL Level Translator with Tri-state Output	MC4368F,L	MC4068F,L,P	10	20	150

**MC4300/MC400 Series loading specified for use with MTTLI Devices

MC4300 MC4000

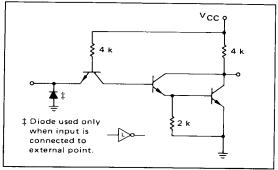


This device consists of two four-channel data selectors with common control lines, constructed from highlevel AND-OR gates and low-level inverters. By selecting one of four logic combinations, information on one of the four data inputs will be routed to the output.

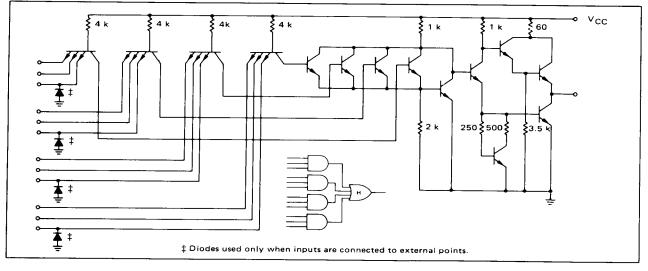
Data selectors are useful in applications where digital data is to be routed from one of several registers or locations to another register or location for processing.

TYPICA	L PROP	AGATION DELAY TIMES (ns) $T_A = 25^{\circ}C$
INPUT	z	CONDITIONS
A	18	X0 = X2 = X3 = logic "0", X1 =
в	15	logic "1". A and B are de-
X1	11	fined by the logic equations.



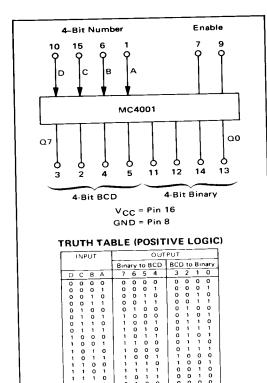


HIGH-LEVEL "AND-OR" GATE



BCD-TO-BINARY/ **BINARY-TO-BCD** NUMBER CONVERTER

> MC4301 MC4001



0011001 0 000001

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The MC4301/4001 serves as a basic building block in Binary-to-BCD and BCD- to-Binary converters. Conversion of any length binary or BCD word can be accomplished by interconnecting MC4001 packages. The MC4001 also contains a full adder and subtractor.

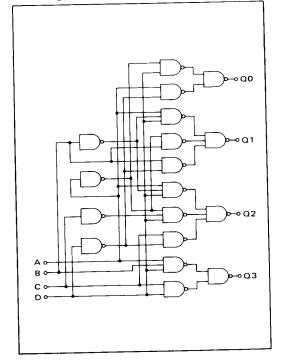
Features: Address times < 45 ns Outputs sink 16 mA Output capacitance < 7.0 pF @ 1.5 V

ENABLE INPUT TRUTH TABLE (POSITIVE LOGIC)

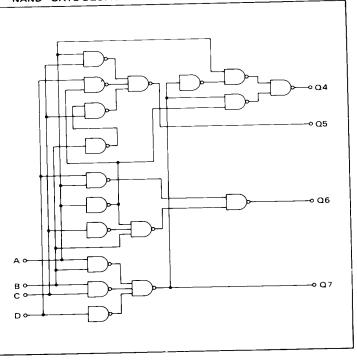
E	Е	Q7	Q6	Q5	Q4	Q3	Q2	Q1	00
0	0	1	1	1	1	1	1	1	1
- ŏ	- 1		1	1	1	1	1	1	1
	0	1	1	1	1	1	1	1	1
$\frac{1}{1}$	1			FUNC	TION	ENAB	LED		

"NAND" GATE EQUIVALENT OF BCD-TO-BINARY CONVERTER

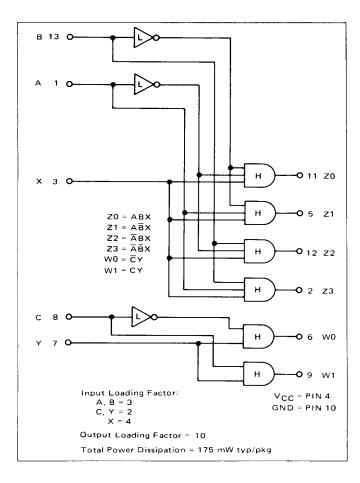
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"NAND" GATE EQUIVALENT OF BINARY-TO-BCD CONVERTER



DUAL DATA DISTRIBUTOR MC4302 MC4002

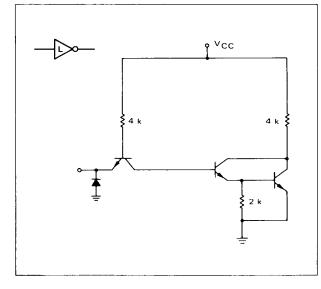


This device consists of two data distributors constructed from high-level AND gates and low-level inverters. One distributes information present at the input line to one of four output lines; the other distributes information present at the input to one of two output lines. The routing path is selected by the logic signals at the control lines A, B or C.

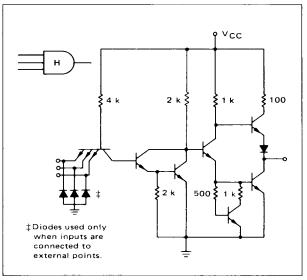
Data distributors are useful in applications where digital data is to be routed from a single register or location to one of several registers or locations for processing.

	L PROPAGA T	₄ = 25°C		
INPUT	zo	Z1	Z2	Z3
A	14.5	10.5	14.5	
 B	14.5	10.5	14.5	10.5
×	10.5	10.5	10.5	10.5
		.		
[INPUT	wo	W1	
	C	W0 14.5	W1 10.5	

LOW-LEVEL INVERTER



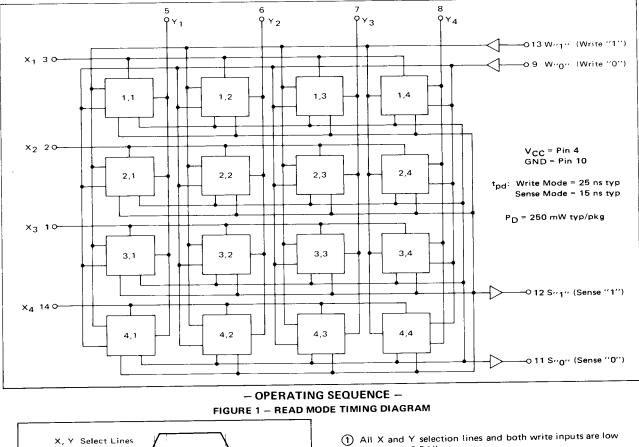
HIGH-LEVEL "AND" GATE



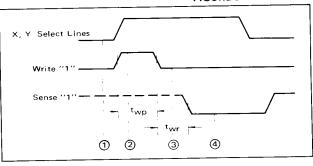
16-BIT SCRATCH PAD MEMORY CELL MC4304 · MC4305 MC4004 · MC4005

This 16-Bit memory cell serves as the basic building block for scratch pad memory systems having cycle times of less than 100 ns. The basic cell provides 16 words of one-bit memory operating in the non-destructive readout (NDRO) mode.

The memory contains 16 flip-flops arranged in a fourby-four matrix. A single bit of the matrix is selected by driving one of four X select lines and one of four Y select lines above the select threshold. Two sense amplifiers are shared by all 16 bits and provide a double rail output from the selected bit. The sense output of many devices can be "wired ORed" together since the output stage does not have a pullup resistor or network. Two write amplifiers allow a "1" or a "0" to be written into a selected bit.



- (less than +0.8 V).
- 2) Desired bit selected by driving the appropriate X and Y select lines more positive than +2.1 V.
- (3) After the turn-on delay time(t_{pd-}), the S"1" output will be low (less than +0.45 V) and the S"0" output will be high (more than +2.5 V), providing that a "1" is stored in the selected bit.



--- ^tpd- ----

2

3

- tpd+ '

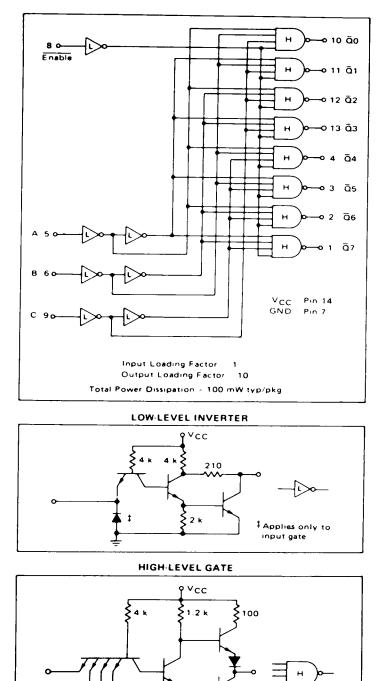
FIGURE 2 - WRITE MODE TIMING DIAGRAM

- (1) All X and Y selection lines and both write inputs are low (less than +0.8 V).
- 2 Bit location selected by driving the appropriate X and Y select lines more positive than +2.1 V. To write a "1", drive the write "1" input more positive than +2.1 V for a minimum time of 25 ns (twp).
- (3) Write "1" line returned to low state.
- (4) The stored bit can be read after the write recovery time (twr) of 40 ns. (The sense output is in an indeterminate state between steps 2 and 4.)

Sense Output

S''1''

MC4306 MC4006



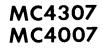
This device converts three lines of input data to a one-of-eight output. The enable line provides an inhibit capability and also allows the decoder to be expanded for larger decoder systems.

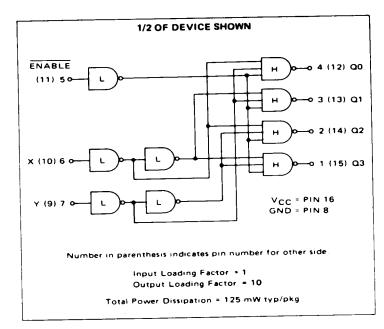
The 3-input/8-output decoder consists of high-level and low-level gates internally connected for minimum power consumption and maximum driving capabilities. The enable gate must be in the low state to perform the decode operation shown in the truth table.

The propagation delays shown in the charts are typical and vary according to loading, interconnection wiring length, and the number of logic levels involved.

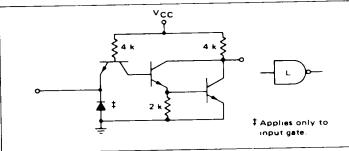
έo				TR	итн ти	ABLE				
с	в	A	ā7	Õ6	Ō5	Ō4	Ō3	ā2	۵ı	ōc
0	0	0	1	1	1	1	1	1	1	0
o	0	1	,	1	,	1	1	1	0	1
0	,	0	1	1 ,	1	1	1	0	1	1
0	1	1	1	1	1	,	0	1	1	1
1	0	0	1	1	1	0	1	1	1	1
,	0	1	1	1	0	1	1	۲	1	,
١	1	0	1	0	1	1	1	1	1	1
1	,	1	0	1	1	1	1	۱	1	1
	State	e	PICAL T Ō1	TURN A 25 ⁰ Ω2	ON DEI ² C, C _T	AY TI 25 pF Q4	MES (6	Â7
) Low	State	" TYF 	T	д 25 ⁰	C, CT -	25 pF			6	
) Low	State	" TYF 	T	д 25 ⁰	C, CT -	25 pF		ā		<u>Õ</u> 7 16 0
INPUT	State	TYF 50	T Q1	A 25°	ο. c _T	25 pF	Ō5	0 11	5	
INPUT	State	түг 50	T Q1 16 0	A 25° Q2 115	C, CT 03 16.0	25 pF Q4 11 5	Q5 16	0 11 5 16	5	16 0
D LOW	State	түг 20 15	T Q1 160 115	A 25 ⁰ Q 2 115 160	C, CT Q3 16.0 16.0	25 pF Q4 11 5 11 5	Q5 16 11	0 11 5 16 0 16	5	16 0 16.0
INPUT A B C	(111 111 113	r TYP 7 5 1 5 1 5 3 5	T Q1 160 115 115 135 CAL T	A 25 ⁶ Q 115 160 115	C, CT Q 3 16.0 16.0 115 13.5 FF DEL	25 pF Q4 11 5 16 0 13 5 AY TI	Q5 16 11 16 13	0 11 5 16 0 16 5 13	5	16 0 16 0 16 0
INPUT A E E	(11 11 13	r TYP 7 5 1 5 1 5 3 5	T Q1 160 115 115 135 CAL T	A 25 ⁰ <u>a</u> 2 11 5 16 0 11 5 13 5 URN-0	C, CT Q 3 16.0 16.0 115 13.5 FF DEL	25 pF Q4 11 5 16 0 13 5 AY TI	Q5 16 11 16 13	0 11 5 16 0 16 5 13	5	16 0 16 0 16 0
INPUT A E E	(11 11 13	* TYP 0 0 5 1 5 3 5 TYPI 00	T Q1 160 115 115 135 CAL T	A 25° $\overline{\Omega}_{2}$ 11 5 16 0 11 5 13 5 URN-O $\Delta_{4} = 25^{\circ}$	C, CT Q3 16.0 16.0 115 13.5 FF DEL C, CT =	25 pF 04 11 5 16 0 13 5 AY TH 25 pF	QE 16 11 16 13	ns)	5 0 5	160 160 160
INPUT A E E INPUT	(111 111 13 7 7	* TVF 00 15 15 15 15 15 15 15 15 15 15 15 15 15	T Q 1 16 0 11 5 11 5 13 5 CAL T T Q 1	A 25° $\overline{\Omega}2$ 11 5 16 0 11 5 13 5 URN-O $\Delta = 25^{\circ}$ $\overline{\Omega}2$	C, CT Q3 16.0 16.0 115 135 FF DEL C, CT = Q3	25 pF Q4 11 5 11 5 16 0 13 5 AY TH 25 pF Q4	 	ns)	5 i.0 .5 .5 .6 0	16 0 16 0 13 5
INPUT A E E INPUT A	C C C C C C C C C C C C C C C C C C C	түр 500 15 15 15 15 15 15 15 15 15 15 15 15 15	T <u>ā</u> 1 16 0 11 5 13 5 CAL T T <u>ā</u> 1 19.5	A 25° $\overline{\Omega}2$ 11 5 16 0 11 5 13 5 CURN-O A = 25° $\overline{\Omega}2$ 14.0	C, CT Q 3 16.0 16.0 115 13.5 FF DEL C, CT = Q 3 19.5	25 pF Q 4 11 5 11 5 16 0 13 5 AY TH 25 pF Q 4 14.0	Q5 16 11 16 13 MES (Q5 19.5	⁷ ² ⁷	5 6 0 5 6 0 5	16 0 16 0 13 5 <u><u><u></u><u></u><u></u><u></u><u></u><u></u><u></u><u></u><u></u><u></u><u>7</u> 19.5</u></u>

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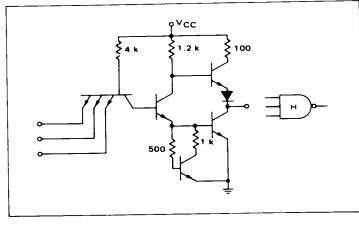




LOW-LEVEL GATE



HIGH-LEVEL GATE



This device converts two lines of input data to a one-of-four output. The enable line provides an inhibit capability and also allows the decoder to be expanded for larger decoder systems.

The dual 2-input/4-output decoder consists of high-level and low-level gates internally connected for minimum power consumption and maximum driving capabilities. The enable gate must be in the low state to perform the decode operation shown in the truth table.

The propagation delays shown in the charts are typical and vary according to loading, interconnection wiring length, and the number of logic levels involved.

TRUTH TABLE

x	Y	00	Q1	Q2	Q3
0	0	0	1	1	1
1	0	1	0	1	1
0	1	1	1	0	1
1	1	1	1	1	0

I = High State

E - 0

0 = Low State

TYPICAL	TURN-ON	DELAY	TIMES	(ns)
	TA =	25°C		

Input	00	Q1	Q2	03
×	11.5	15.5	11.5	15.5
¥	11.5	115	15.5	15.5
E	13.5	13:5	13.5	13.5

TYPICAL TURN OFF DELAY TIMES (¥5)
T _A = 25 ^o C	

Input	00	Q1	Q2	Q3
×	14.0	19.0	14.0	19.0
¥	14.0	14.0	19.0	19.0
Ē	14.5	14.5	14.5	14.5

MC4308 MC4008

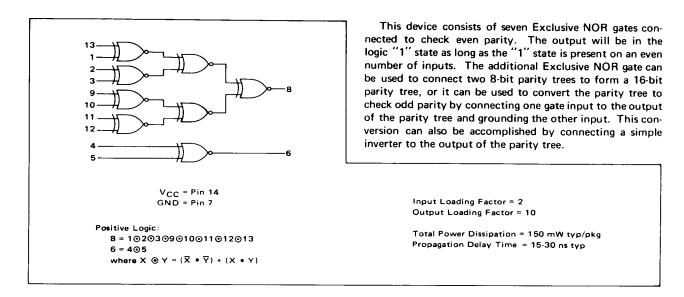
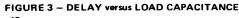
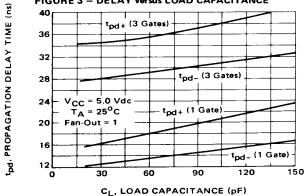
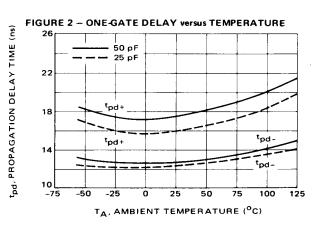


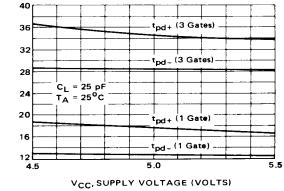
FIGURE 1 - THREE-GATE DELAY versus TEMPERATURE (us) 55 t_{pd}, PROPAGATION DELAY TIME 50 pF 25 pF 45 nd 35 25 tp 15 125 -50 -25 0 25 50 75 100 -75 TA, AMBIENT TEMPERATURE (°C)









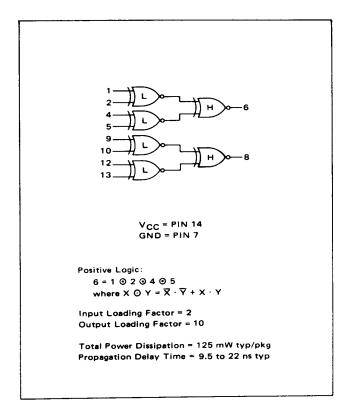


TYPICAL PROPAGATION DELAY TIMES

PROPAGATION DELAY TIME (ns)

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Three Exclusive NOR gates are connected together to form each of the two 4-bit parity trees in the package. An even number of logic "1" states on the inputs will result in a logic "1" output state. An odd parity checker can be made by connecting an inverter to the output of the device.

This function is constructed using low and high-level Exclusive NOR gates connected as shown in the logic diagram to maximize output drive capability and minimize power dissipation.



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4 k

2

‡Applies only to input gate.

4 k

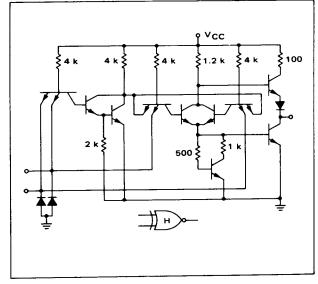
4 6

2 4

Vcc

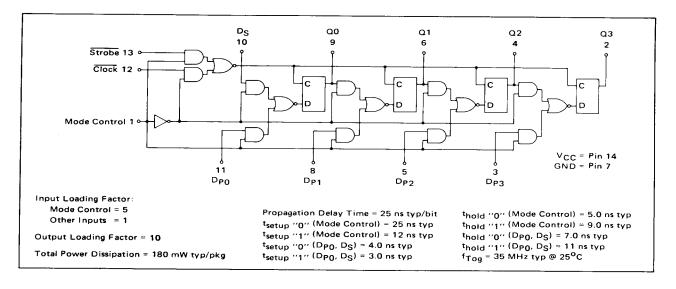
4 k

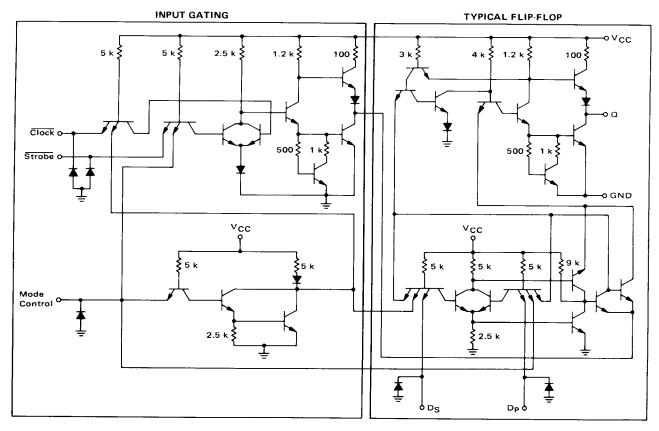




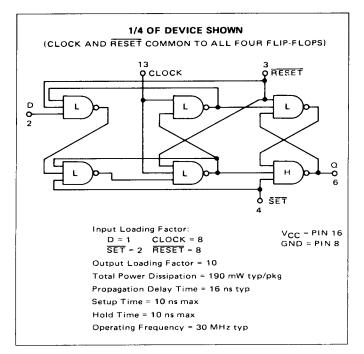
MC4312 MC4012

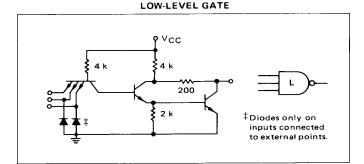
This 4-bit register provides parallel or serial data entry and retrieval, determined by the logic state of the mode control input. For parallel operation, set the mode control to the logic "1" state and strobe the information at the Dp inputs into the register. Serial left-shift operation is achieved in this mode by connecting the Q outputs to the Dp inputs of the previous stage. For serial right-shift operation, set the mode control to logic "0" and clock data into the register from DS.



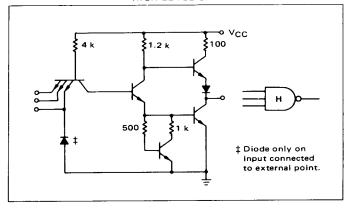


MC4315 MC4015



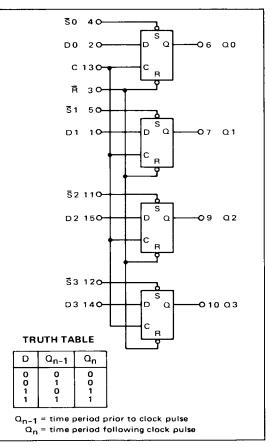


HIGH-LEVEL GATE



This quad type D flip-flop triggers on the positive edge of the clock input. During the clock transition the state of the D input is transferred to the Q output. The device is useful in shift registers and simple counters.

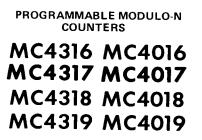
Power dissipation is minimized and output drive capability is maximized by connecting low and high-level gates as shown by the logic diagram to form each of the four flip-flops.



OPERATING CHARACTERISTICS

Data must be present at the D input 10 ns prior to the rise of the clock, and remain 10 ns after the clock signal rises. Data may be changed any time during the clock cycle except the interval between the setup time (10 ns) and the hold time (10 ns) without affecting the operation of the flip-flop. The data input is inhibited when the clock is high. When the clock is in the low state, the input steering section continually reflects the state of the D input. Information present at the D input during the time interval between the setup and hold times is transferred to the bistable section on the positive edge of the clock, and outputs Q and \overline{Q} respond accordingly.

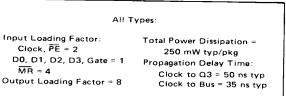
The flip-flops can be set or reset directly at any time, regardless of the state of the clock, by applying a low state to the direct Set or Reset inputs.

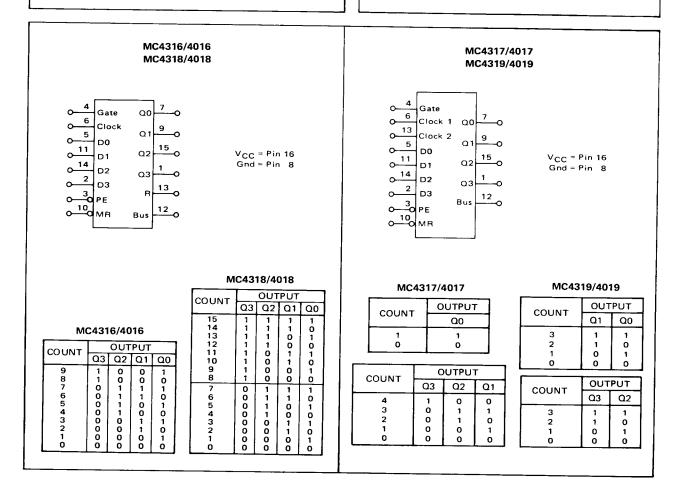


The monolithic devices are programmable, cascadable, modulo-N-counters. The MC4316/4016 can be programmed to divide by any number (N) from 0 thru 9, the MC4318/4018 from 0 thru 15. The MC4317/4017' consists of a modulo 2 counter which can be programmed to divide by 0 or 1 and a modulo 5 counter which can be programmed to divide by any number from 0 to 4. The MC4319/4019 contains two modulo 4 counters which can be programmed to divide by any number from 0 to 4. The MC4319/4019 contains two modulo 4 counters which can be programmed to divide by any number from 0 to 3. The parallel enable (PE) input enables the parallel data inputs D0 thru D3. All zeros are entered into the counter by applying a logic "0" level to the master reset (MR) and PE inputs. This

causes the counter to stop counting (count = 0). All data inputs are independent of the logic level of the Clock. Modulo-N counters are useful in frequency synthesizers, in

phase-locked loops, and in other applications where a simple method for frequency division is needed.





(CONTINUED)

OPERATING CHARACTERISTICS

Basic operation of the MC4316/4016 and MC4318/4018 is the same. When operated as single stages, the Gate and Clock inputs must be tied together. The internal pullup resistor must be connected to the Buss node (pin 13 to pin 12). The programmable counter is set to count down by a pre-determined number (N) before recycling, according to the binary code present at the parallel preset inputs, PO thru P3 (see the truth table). The binary information at inputs PO thru P3 is preset into the counter after applying a logic "O" to the $\overline{\text{PE}}$ input. Data may be entered synchronously or asynchronously while $\overline{\text{PE}}$ is low, or when outputs Q0, Q1, Q2 and Q3 are in the logic "O" state and the Clock is low.

The counters may be set to divide by 10 (MC4316/4016) or 16 (MC4318/4018) regardless of preset input states by applying a logic "0" to the Buss node. This, in effect, disables the preset inputs and

causes a logic "0" to appear at the preset of each flip-flop of the counter. If a binary number greater than nine (1001) is applied to the preset inputs of the MC4316/4016, the counter will ignore the most significant bitand recognize only the three least significant bits. Cascading of Counters

To cascade counters (Figure 1):

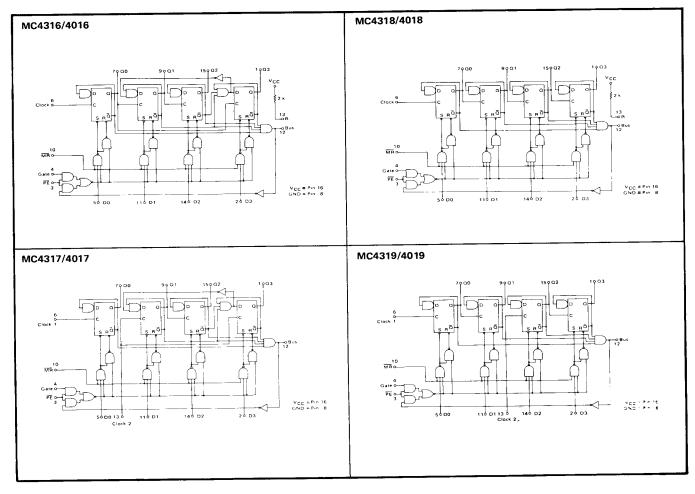
- 1. Connect Gate inputs of all stages to the Clock of the first stage.
- 2. Connect all Buss outputs to one common pullup resistor (2.0 kilohms, internal).
- 3. Connect the Clock input of each stage after the first stage to the Q3 output of the previous stage.
- 4. Take the divide-by-N pulse from the Buss outputs.

When cascaded, the count mode of the entire string of counters is defined by:

$$N = N_0 + 10 N_1 + 100 N_2 + \dots$$
 (MC4316/4016)

$$N = N_0 + 16 N_1 + 256 N_2 + \dots$$
 (MC4318/4018)

where N_0 , N_1 , N_2 , . . . are the BCD or binary numbers programmed at the zero, first, second, . . . stages.



LOGIC DIAGRAMS

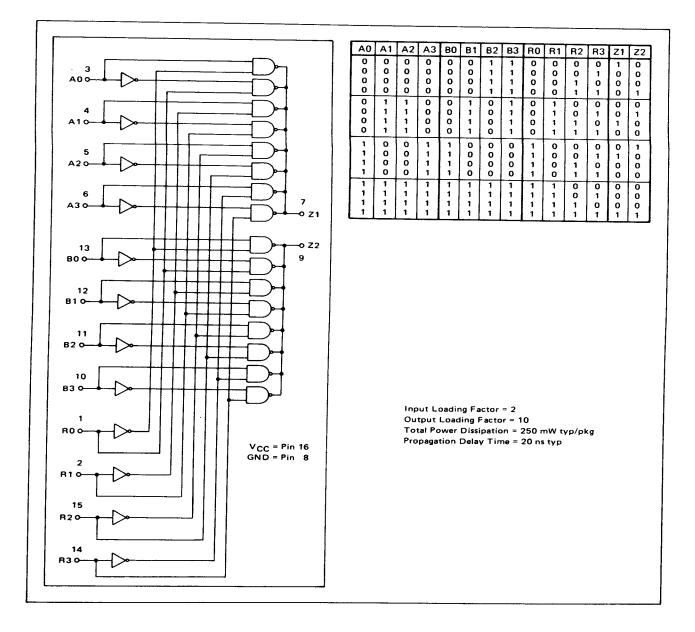
or

MC4321/4021 MC4322/4022

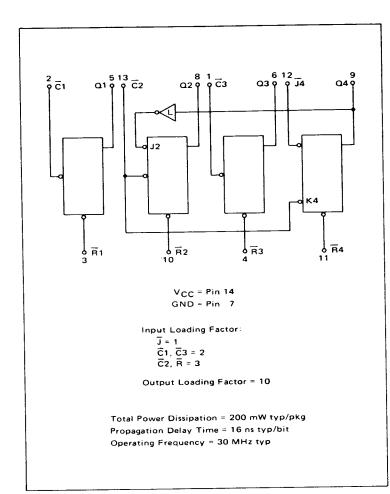
The 4-bit comparator compares four bits of input information to four bits of reference information. When each bit of the input information is the same as its corresponding reference information, bit for bit, the output of the comparator will be in the high ("1") state. For any other condition, the output of the comparator will be in the low ("0") state.

In this dual 4-bit comparator, the four reference inputs (R) serve both comparators. There is no interrelation between the A and B data inputs of the dual comparator. Output Z1 reflects comparison of the A and R bits, while output Z2 shows conditions at inputs B and R.

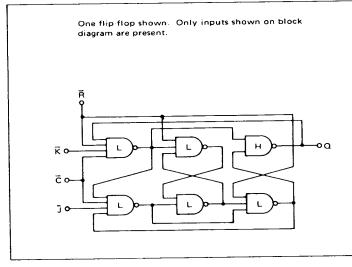
The MC4021 has open-collector outputs; the MC4022 has totem-pole outputs.



MC4323 MC4023

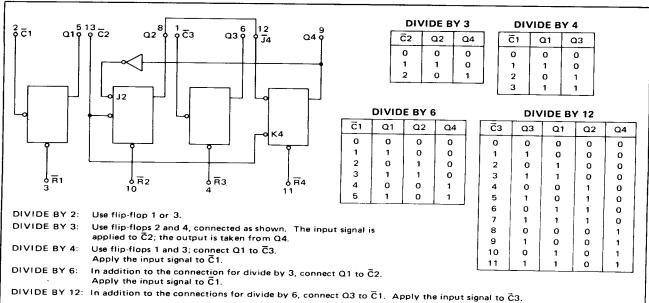


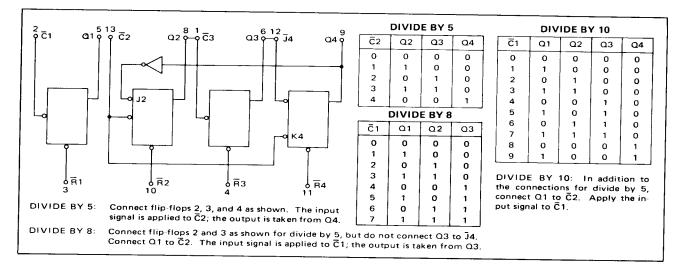
LOGIC DIAGRAM

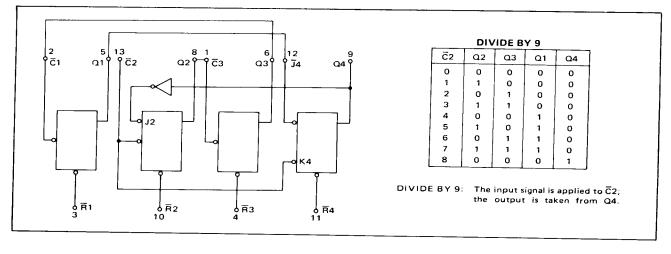


This device is a 4-bit counter with internally connected feedback. Inputs and outputs can be connected to count to any number between two and twelve except seven and eleven. Reset inputs are provided on each flip-flop to allow direct setting of the Q outputs to zero any time during the counting cycle.

Each flip-flop in the counter is built from high and low-level gates as shown by the logic diagram. The flip-flops and the feedback inverter are connected as shown by the block diagram to provide minimum power dissipation and maximum drive capability.



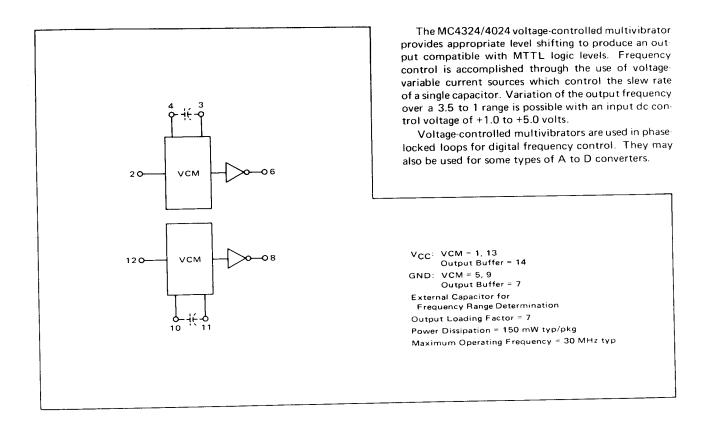


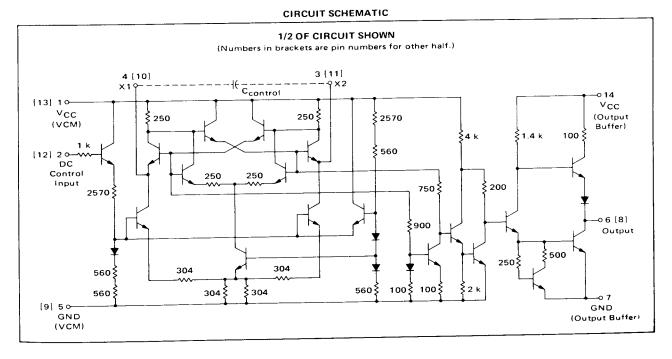


112

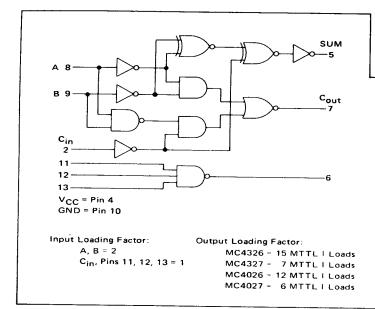
COUNTING SEQUENCES

MC4324 MC4024





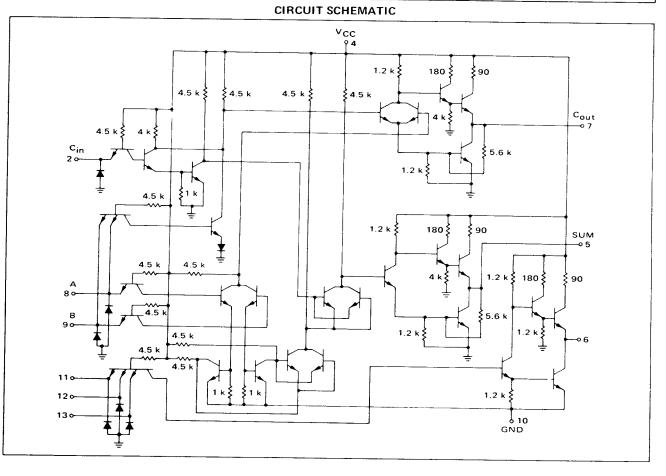
MC4326 · MC4327 MC4026 · MC4027



These full adders are designed for serial and ripple-carry parallel adder systems. True Sum and Carry are produced at the output from the input information. A separate 3-input NAND gate is provided on the monolithic chip to provide the inverted Sum or Carry output.

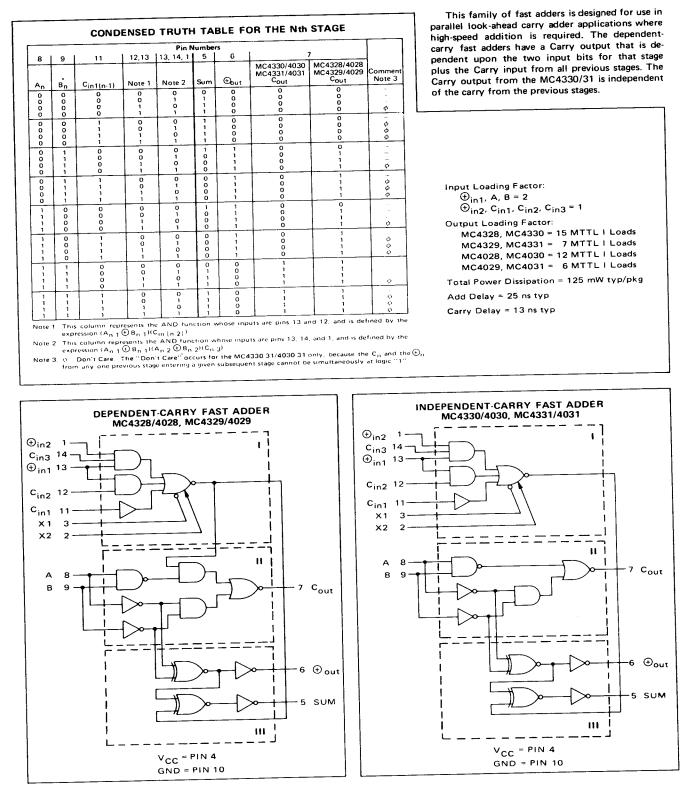
TRUTH TABLE Input Pins **Output Pins** в Α Cin SUM Cout Ó

Total Power Dissipation = 90 mW typ/pkg Add Delay = 25 ns typ Carry Delay = 13 ns typ

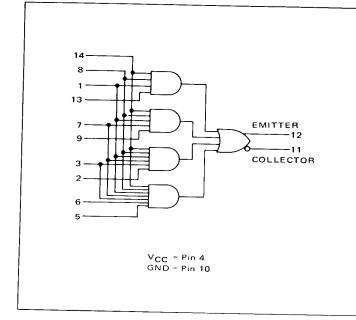


ADDERS

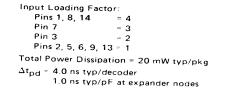
MC4328 thru MC4331 MC4028 thru MC4031

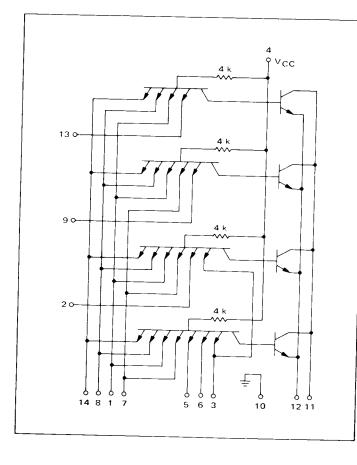


MC4332 MC4032



This 4-wide 4, 5, 6, 7 input AND-OR expander provides the necessary logic for carry decoding between look-ahead carry adder stages using the MC4328/29 and MC4330/31 fast adders.





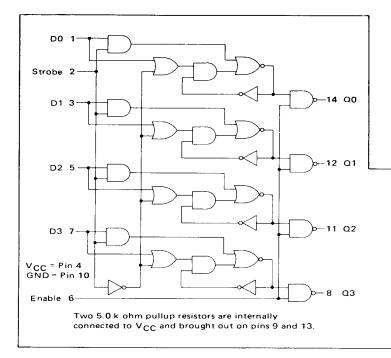
TYPICAL APPLICATION

The MC4328/29 and MC4330/31 adders can be used with the MC4332 Carry Decoder to build 8-stage look-ahead carry subsystems. (See the MC4328-31) data sheet for a diagram.) Each stage examines the carry outputs from all previous stages while adding bits A and B for that stage. The carry outputs of the first and eighth stages are dependent upon the carry inputs from previous stages; thus the MC4328/29 adder is used for stages one and eight while the MC4330/31 adder is used for stages two through seven. The MC4332 Carry Decoder is used to expand the lookahead carry input capability required for stages four through eight.

The add delay of an eight stage adder is equal to the sum of the add delay and the delay from the A and B inputs to the \oplus output of one stage. Thus the typical add delay for an 8-stage adder is 25 ns +13 ns or 38 ns typical.

When expander inputs are not used they should not be connected to any external point. This minimizes possible problems resulting from noise pick-up. QUAD LATCH (Open Collector)



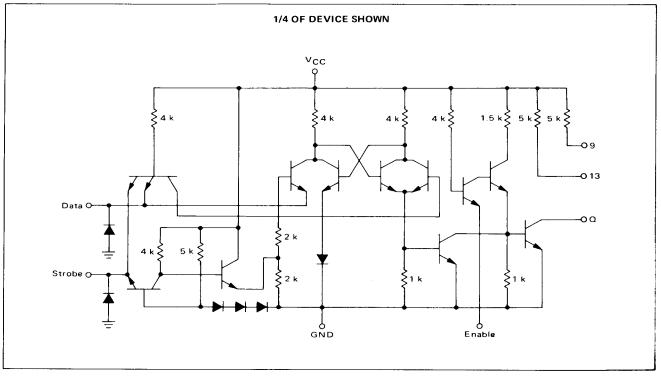


This monolithic device consists of four latch circuits with open collector outputs, common Strobe input, and output enable input. The output of each latch will follow the data input when the Strobe input is in a logical "1" state. When the Strobe is in a logical "0" state, the latch will store the logic state of the data input just prior to the change of the Strobe from a "1" level to a "0" level.

The open collector outputs make this device useful for bussing or wire ORing outputs together. Two 5.0 k ohm resistors are available in the package to provide the passive pullup function in wired-OR or bussed operation. The output enable is useful where it is desirable to gate information out of the latches according to a predetermined timing scheme.

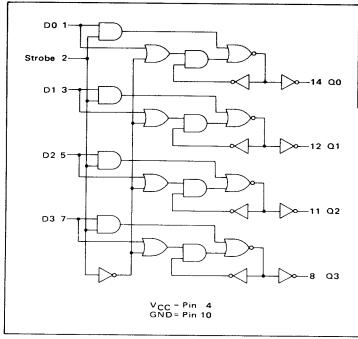
Input Loading Factor (MTTL I Loads): Data Input (Strobe High) -- MC4335 = 4.2 MC4035 = 4.0 Data Input (Strobe Low) -- MC4335 = 1.1 MC4035 = 0.9 Output Enable -- MC4335 = 4.0 MC4035 = 3.6 Strobe -- MC4335 = 5.2 MC4035 = 5.2 Output Loading Factor (MTTL I Loads): MC4335 = 7 (I_{OL} = 9.3 mAdc) MC4035 = 7 (I_{OL} = 11.6 mAdc) Total Power Dissipation = 140 mW typ/pkg Propagation Delay Time = 25 ns typ

CIRCUIT SCHEMATIC

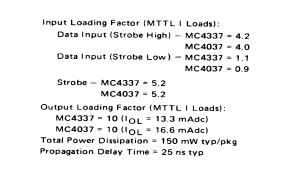


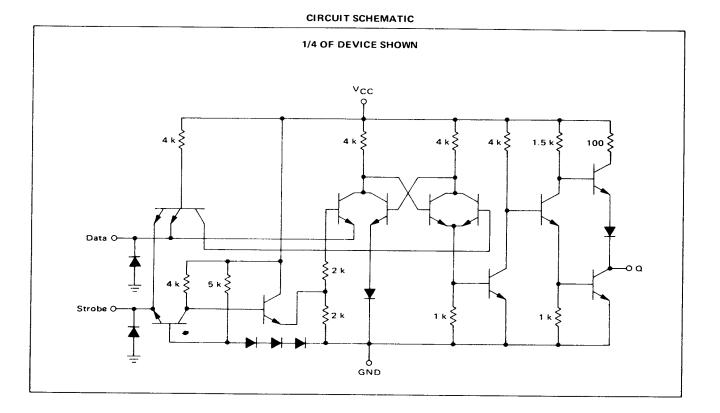
QUAD LATCH

MC4337 MC4037



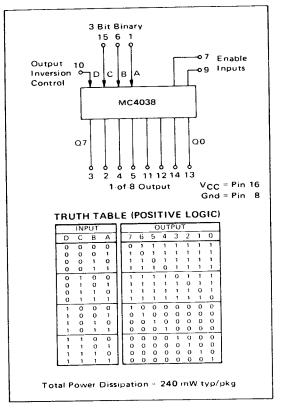
This monolithic device consists of four latch circuits with active pullup networks for high capacitive load drive capability. Separate data inputs and a common Strobe input are provided. Information present on the data inputs prior to the negative edge of the strobe input will be stored in the latch. When the strobe input is high, the Q output will follow the data input.





INVERTING/NON-INVERTING ONE-OF-EIGHT DECODER

MC4338 MC4038

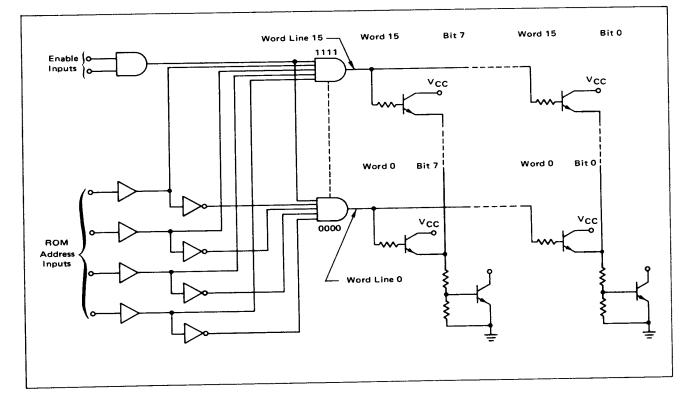


A 3-bit binary address selects the desired word for the 8-bit output. The inversion control, D, selects half of the memory chip with the bit pattern that defines a 1-of-8 decoder function. When D is a logic "0", the selected output is designated as a logic "0". A logic "1" on D produces a logic "1" on the selected output.

Features: Address times < 45 ns Outputs sink 20 mA Output capacitance < 7.0 pF @ 1.5 V Wired OR capability to 64 memories

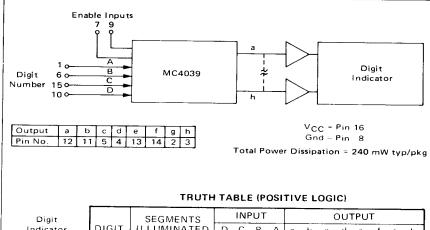
ENABLE INPUT TRUTH TABLE (POSITIVE LOGIC)

E	E	Q7	Q6	Q5	Q4	Q3	Q2	Q1	00
0	0	1	1	1	1	1	1	1	1
0	1	1	1	1	1	1	1	1	1
1	0	1	1	1	1	1	1	1	1
1	1			FUNC	TION	ENAB	LED		



SEVEN-SEGMENT CHARACTER GENERATOR

> MC4339 MC4039



DIGIT ILLUMINATED Indicator D С В А а \mathbf{b} d е f h с g 0 1 a,b,c,d,e,f b,c 0 0 1 1 0 1 0 0 0 0 0 0 0000 00000 000000 1 а 1 2 3 a,b,d,e,g 0 1 0 0 1 0 0 1 0 1 1 a,b,c,d,g 1 1 4 b,c,f,g a,c,d,f,g c,d,e,f,g 0 0 0 1 1 0 1 00000 0000 1 0 0 0 1 0 0 0 1 5 ò 001 1 6 1 1 0 1 1 0 ò a,b,c 1 1 ò 8 a,b,c,d,e,f,g 1 00 ō 0 0 0 0 0 0 n n 9 a,b,c,f,g 1 0 ō ō ŏ ŏ NONE ŏ 0 1 1 1 1 1 h(Ext.) 1 0 1 1 Ó 0 g 1 0 0 1 1 1 1 1 0 1 d NONE h 1 1 0 1 1 NONE ò 1 1 1 NONE 1

The MC4339 can directly

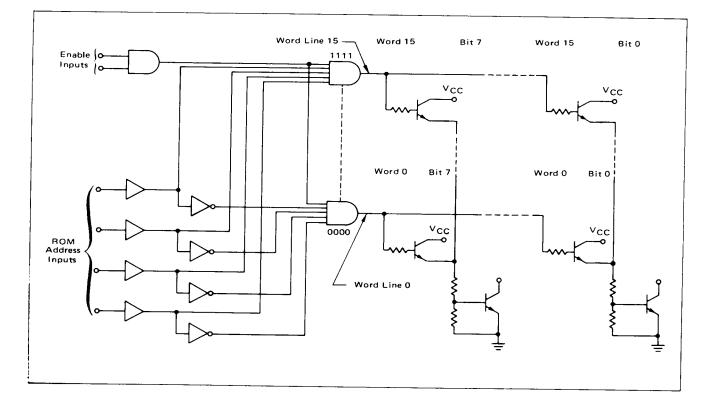
operate low-voltage lamp indicators. A four digit binary input is translated into combinations of the eight outputs. These combinations correspond to different illuminated segments of the seven-bar digit indicator. The input and output codes with their related numerical digits are shown in the diagram. The enable inputs can be used for automatic blanking.

Features:

Address times < 45 ns Outputs sink 20 mA Output capacitance < 7.0 pF @ 1.5 V Wired OR capability to 64 memories

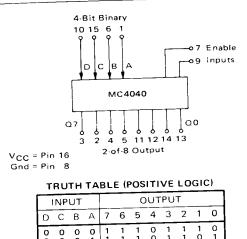
ENABLE INPUT TRUTH TABLE (POSITIVE LOGIC)

Ę	Е	а	ь	с	d	е	f	g	h
0	0	1	1	1	1	1	1	1	1
0	1	1	1	1	1	1	1	1	1
1	0	1	1	1	1	1	1	1	1
1	1		FL	INC	TION	EN	ABL	ED	•



BINARY TO TWO-OF-EIGHT DECODER

MC4340 MC4040



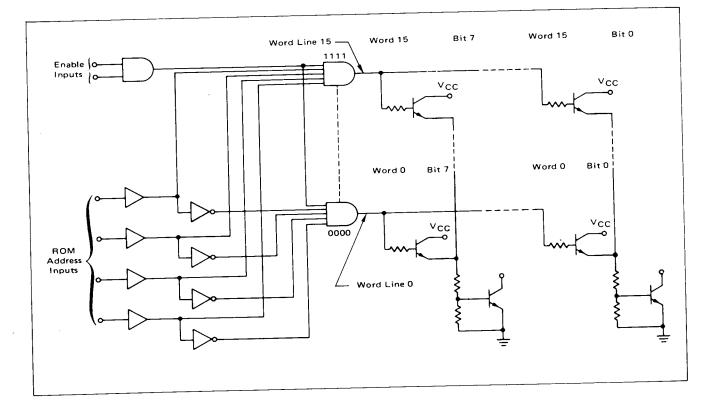
0 0 0 0 Ó 0 1 1 1 0 1 1 0 1 1 1 0 1 1 0 1 n Total Power Dissipation = 200 mW typ/pkg This device, with two enable inputs, transforms any 4-bit binary number to a 2-of-8-bit coded number. The device can also be thought of as a dual binary to 1-of-4 decoder.

Features:

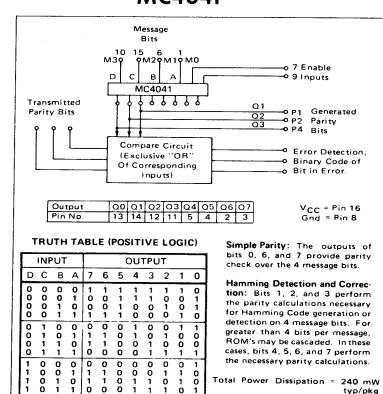
Address times < 45 ns Outputs sink 20 mA Output capacitance < 7.0 pF @ 1.5 V Wired OR capability to 64 memories

ENABLE INPUT TRUTH TABLE (POSITIVE LOGIC)

E	E	Q7	Q6	Q5	Q4	03	Q2	Q1	00
	0	1	1	1	1	1	1	1	1
	1	1	1	1	1	1	1	1	
	0	1	1	1	1	1	1	1	1
1	1			FUNC	CTION	ENAB	LED		



SINGLE-ERROR HAMMING CODE DETECTOR AND GENERATOR MC4341 **MC4041**



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o O

1 1 0 0

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1 1 1

100

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> 0 1 1

1 0 0 1 0 100 1 1 00

1

Total Power Dissipation = 240 mW typ/pkg

For more information on this function and its uses, see Application Note AN-446

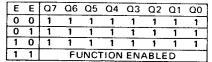
The MC4041 is a programmed 128-Bit Read Only Memory suitable for a variety of error detection and correction applications

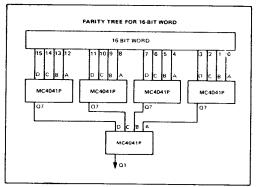
Simple parity trees for error detection can be constructed using the MC4041P as the basic building block. Also, more complex error control schemes, such as Hamming single error detection and correction, can be implemented with this device.

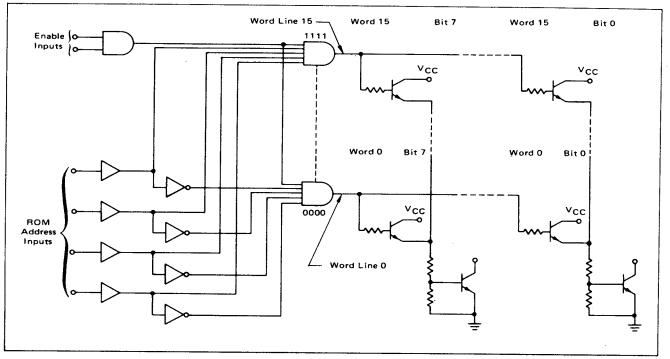
Features:

Address times < 45 ns Outputs sink 20 mA Output capacitance < 7.0 pF @ 1.5 V Wired OR capability to 64 memories

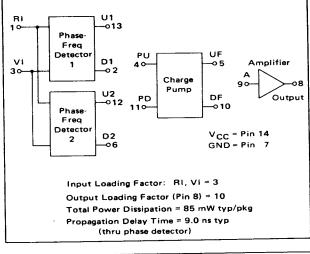
ENABLE INPUT TRUTH TABLE (POSITIVE LOGIC)







MC4344 MC4044

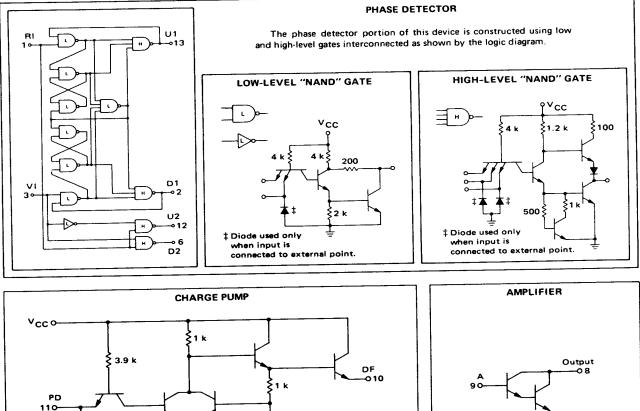


This device contains two digital phase detectors and a charge pump circuit which converts MTTL inputs to a dc voltage level for use in frequency discrimination and phase-locked-loop applications.

The two phase detectors have common inputs. Phase-frequency detector 1 is locked in (indicated by both outputs high) when the negative transitions of the variable input (VI) and reference input (RI) are equal in frequency and phase. If the variable input is lower in frequency or lags in phase, the U1 (up) output goes low; conversely the D1 (down) output goes low when the variable input is higher in frequency or leads the reference input in phase. It is important to note that the duty cycles of the variable input are not important since negative transitions control system operation.

Phase detector 2, on the other hand, is locked in when the variable input phase lags the reference phase by 90° (indicated by the U2 and D2 outputs alternately going low with equal pulse widths). If the variable input phase lags by more than 90°, U2 will remain low longer than D2, and, conversely, if the variable input phase lags the reference phase by less than 90°, D2 remains low longer. In this phase detector the variable input and the reference must have 50% duty cycles.

The charge pump accepts the phase detector outputs (U1 or U2 applied to PU, and D1 or D2 applied to PD) and converts them to fixed amplitude positive and negative pulses at the UF and DF outputs respectively. These pulses are applied to a lag-lead active filter, which incorporates external components, as well as the amplifier provided in the MC4344/4044 circuit. The filter provides a dc voltage proportional to the phase error.

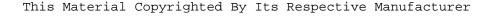


ξ1 κ

UF

123

-05



PU

QUAD PREDRIVER

DUAL LINE SELECTOR

MC4342 MC4042

MC4343 MC4043

The MC4042 and MC4043 are designed for magnetic memory driver/selector applications.

The MC4042 monolithic quad predriver consists of four highspeed switching transistors, each driven by an MTTL compatible NOR gate. Each NOR gate has an individual address input and a common timing input. The inputs of the MC4042 can be driven directly with standard MTTL decoders such as the MC4006 binary to one-of-eight decoder or the MC4007 dual binary to one-of-four decoder. The open-collector output transistor of the MC4042 will sink 50 mA.

The MC4043 monolithic dual line selector consists of two highspeed 400 mA switches driven by MTTL compatible NOR gates. Each NOR gate has an individual address input and a common timing input. The address and timing inputs of the MC4043 can also be driven directly with standard MTTL decoders such as the MC4006 and MC4007.

The MC4042 and MC4043 input circuits are the same, but the output circuitry is different as shown in the device schematics. The output transistors of both devices have a minimum BV_{CEX} of 15 volts, and are gold doped to increase switching speeds.

Many memory predriver applications employ transformer coupling between the predriver and driver stages. In such designs, large

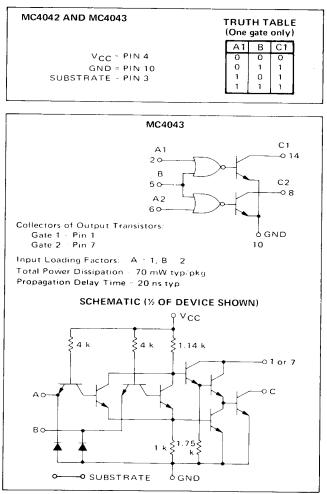
MC4042 VCC 2 --05 A 1 C1 20 -01 в 110 C2 A2 -07 60 СЗ A3 -08 90 C4A4 014 130 GND 10 Input Loading Factors: A = 1, B ... 4 Total Power Dissipation - 120 mW typ/pkg Propagation Delay Time = 15 ns typ SCHEMATIC (¼ OF DEVICE SHOWN) 9Vcc 4 k 4 6 14 k § 860 °Vcc₂ оc AC BO ₹8 k 1 k - SUBSTRATE 0 δ GND

voltage overshoots occur due to the transformer inductance and high-speed switching currents. The collector of the MC4042 is internally clamped to prevent the collector from exceeding the maximum rated voltage during the switching transitions. The voltage applied to the diode clamp, pin 5, should be the same or greater than the collector voltages at pins 1, 7, 8, and 14, to prevent the diode clamp from being forward biased during nonswitching periods. The output transistor is driven with a conventional totem pole arrangement to provide active pullup and pulldown.

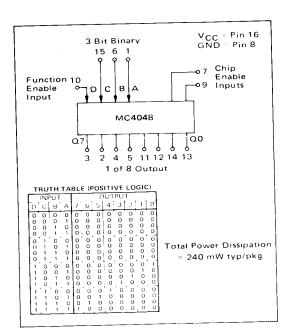
The collectors of the pullup transistors of the MC4043 are available at pins 1 and 7. An external load resistor to V_{CC} must be provided. This reduces power dissipation of the package and provides a means by which the speed of the device can be varied by changing the value of the pullup resistance.

The internal decoding circuitry of the MC4043 is such that both switches can be turned on at one time. However, due to power limitations, care must be taken to ensure that only one switch is turned on at any one time.

The MC4042 and MC4043 can provide a memory system with an inexpensive, reliable, fast drive system. They are also useful as relay or lamp drivers, high fan-out gates, and MOS drivers.



MC4348 MC4048



ENABLE INPUT TRUTH TABLE (POSITIVE LOGIC)

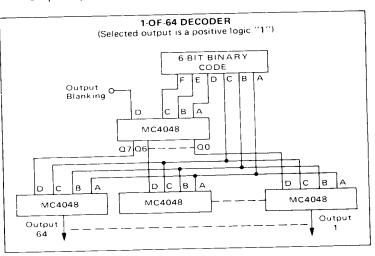
E	E	Q7	Q6	Q5	Q4	O 3	Q2	Q1	Q0
	0	1	1	1	1	1	1	1	1
	1	1	1	1	1	1	1	1	1
	0	1	1	1	1	1	1	1	1
1	1		L	UNC	TION	ENA	BLE	5	

A 3-bit binary address selects the desired word for the 8-bit output, and the selected output goes to a logic "1". The function enable input, D, is useful for expansion of the decoding function. When D is a logic "0" all outputs are logic "0". A logic "1" on D produces a logic "1" on the selected output.

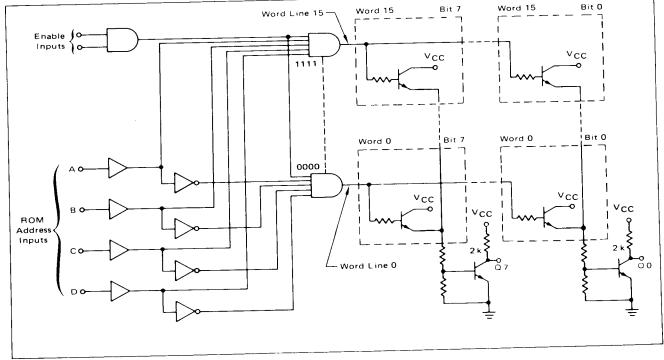
Features:

Address times < 50 ns Outputs sink 16 mA

Output capacitance < 7.0 pF @ 1.5 V



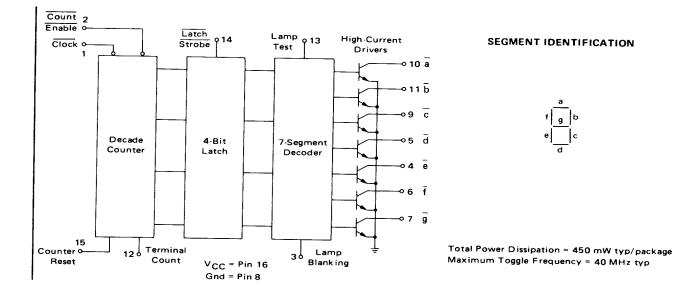
REPRESENTATIVE CIRCUIT SCHEMATIC



MC4350 MC4050

This monolithic integrated circuit combines the functions of a binary coded decimal counter, a four-bit latch, and a seven-segment decoder/driver. Designed primarily for counting applications such as frequency counters, the circuit contains a leading zero blanking feature activated through the Reset input. For this reason the MC4350/ 4050 is useful in systems using automatic decimal ranging and/or automatic time base selection. A Count Enable input gates the clock input without restrictions on the clock level and without false-clocking the counter. The Terminal Count is high driving the ninth count, allow-

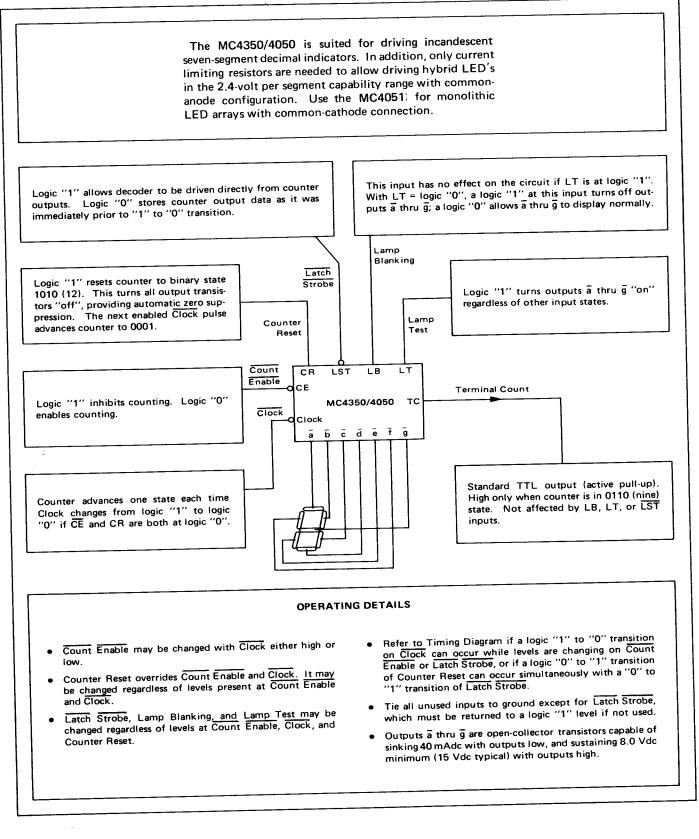
ing synchronous or asynchronous counter operation when used in conjunction with the Count Enable input and external gating. The Counter Reset places the counter in a non-NBCD state, turning off the output driver transistors when transferred through the latch and decoded. The latch section admits information while the Latch Strobe is high and latches the data on the negative edge of the strobe. The seven-segment decoder/driver provides up to 40 mA drive capability for displays requiring current sinking in the active mode. A lamp blanking input provides intensity modulation. A lamp test feature is also available.



FUNCTIONAL TRUTH TABLE

				INF	PUT						OUT	PUT			·
FUNCTIO	DN	CLOCK	CE	CR	LST	LT	LB	тс	ā	Б	ī	ā	e	Ŧ	g
Lamp		×	х	х	×	1	X	_	0	0	0	0	0	0	
Lamp Blan		×	×	×	×	0	1	-	1	1	1	1	1	1	1
	able	X	x	1	1	0	0	0	1	1	1	1	1	1 1	l i
En	able	Ρ	1	0	1	0	0	0	1	1	1	1	1	1	i
		P1	0	0	1	0	0	0	1	0	0	1	1	1	1
	2	P2	0	0	1	0	0	0	0	0	1	0	Ó	1	l o
	3	P3 P4	0	0	1	0	0	0	0	0	0	0	1	1	ŏ
	4		0	0	1	0	0	0	1	0	0	1	1	0	o
State	5	P5	0	0	1	0	0	0	0	1	0	0	1	0	0
Sequence	6	P6 P7	0	0	1	0	0	0	0	1	0	0	0	Ō	ō
	8	P8	0	0		0	0	0	0	0	0	1	1	1	1
	9			0	1	0	0	0	0	0	0	0	0	0	0
	0	P9 P10	0	0	1	0	0	1	0	0	0	0	1	0	0
	1 I	P11	0	0	21	0	0	0	0	0	0	0	0	0	1
La	itch	P	ŏ	ŏ	6	0	0	0	1	0	0	1	1	1	1
					<u> </u>		0	0	1	0	0	1	1	1	1
P = any num	nber d	of pulses r	nav be	annlie	ч										
P _n = n pulses	on th	e Clock i	nout	- up prie	Γ		3.0 V								
X = Don't ca						L	0 V								

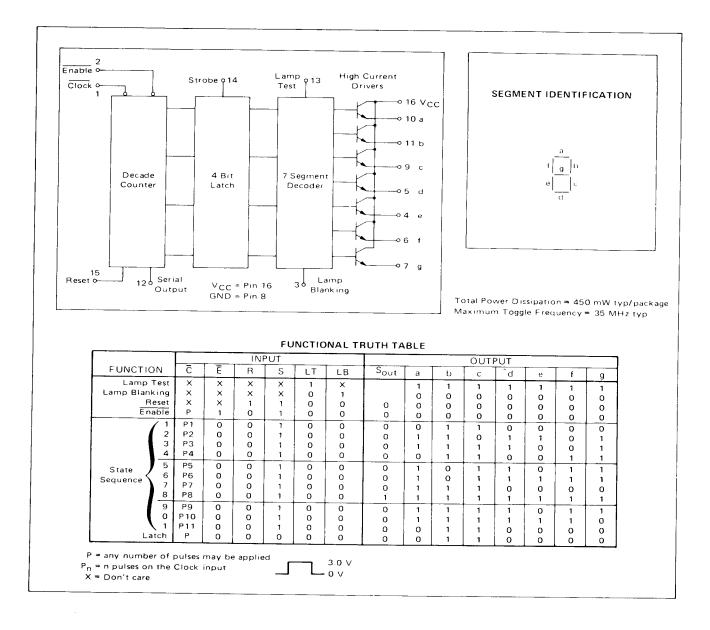
MC4350 MC4050 (CONTINUED)



MC4351 MC4051

This device is a monolithic MSI integrated circuit combining the functions of an NBCD counter, four-bit latch, and a seven-segment decoder/driver. The counter advances on the negative edge of the Clock, subject to control by the Enable input. The Serial Output is high driving the ninth count, allowing synchronous or asynchronous counter operation when used in conjunction with the Enable input and some external gating. The counter Reset places the counter in a non-NBCD state, turning off the output driver transistors when transferred through the latch and decoded. This feature gives automatic suppression of leading zeros in the display. The latch section admits information while the Strobe is high and latches the data on the negative edge of the strobe. The seven-segment decoder/ driver is active high and will source up to 40 mA at a 10% duty cycle or 15 mA at a 100% duty cycle. A lamp blanking input is provided for intensity modulation. A lamp test feature is also available.

The output structure of this device is an open emitterfollower configuration whose equivalent circuit is a voltage source with a relatively small series resistance. Although this resistance increases when the output is grounded, the situation is potentially destructive to the device. When the outputs are in the high ("1") state, they should not be connected to ground through an impedance of less than 100 ohms.

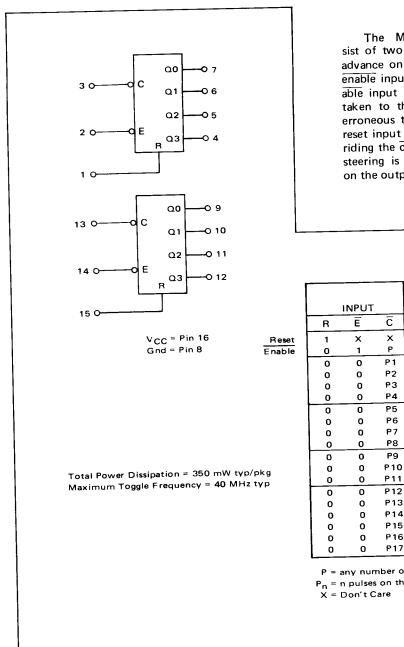


DUAL DECADE COUNTER

MC4352 MC4052

DUAL HEXADECIMAL COUNTER

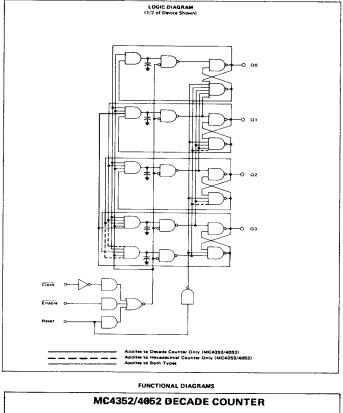
MC4353 MC4053

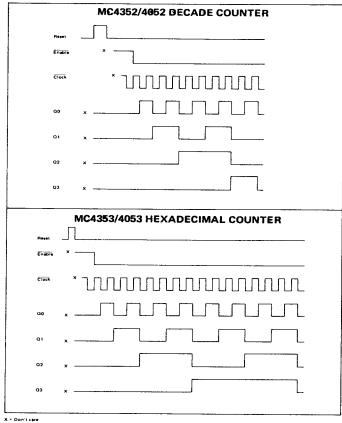


The MC4352/4052 and MC4353/4053 consist of two independent up counters. The counters advance on the negative edge of the clock when the enable input is low. The count is held when the enable input is high. The enable input should not be taken to the high level while the clock is high, as erroneous triggering can result. A high level on the reset input places the counter in the 0000 state, overriding the clock and enable inputs. As charge control steering is utilized in this design, capacitive loading on the outputs should be kept at a minimum.

			N	AC4352	2/4052		N	AC435	3/4053			
ı	NPUT			OUT	PUT		OUTPUT					
R	Ē	Ē	03	02	Q1	00	Q3	Q2	01	00		
1	×	×	0	0	0	0	0	0	0	0		
0	1	Р	0	0	0	0	0	0	0	0		
0	0	P1	0	0	0	1	0	0	0	1		
ō	0	P2	0	0	1	0	0	0	1	0		
õ	0	P3	0	0	1	1	0	0	1	1		
0	0	P4	0	1	0	0	0	1	0	0		
0	0	P5	0	1	0	1	0	1	0	1		
õ	ō	P6	0	1	1	0	0	1	1	0		
õ	ō	P7	0	1	1	1	0	1	1	1		
ō	ō	P8	1	0	0	0	1	0	0	0		
0	0	P9	1	0	0	1	1	0	0	1		
0	0	P10	0	0	0	0	1	Ó	1	0		
0	0	P11	0	0	0	1	1	0	1	1		
0	0	P12					1	1	0	0		
õ	ō	P13		A F	ove		1	1	0	1		
ō	ō	P14	1		Jence		1	1	1	0		
õ	ō	P15	1		eats		1	1	1	1		
0	0	P16		ner	leats		0	0	0	0		
Ō	0	P17					0	0	0	1		
0 P = a		nber of	f pulses e Clock	ed	0		0 3.0 \ - 0 V					
	on't C								0 0			

FUNCTIONAL TRUTH TABLE





DUAL DECADE UP/DOWN COUNTER

MC4354 MC4054 DUAL BINARY UP/DOWN COUNTER

MC4355 MC4055

These devices are presettable, synchronous (clocked) up/down coutners. The MC4354/4054 is a decade counter consisting of two separate but cascaded counters. One counter counts the least significant decade, and the other the most significant decade. The counter counts to 1001 1001, or 99, before resetting to 0000 0000. The MC4355/ 4055 is a binary counter consisting of two separate hexadecimal counters which are cascaded. This counter is essentially an 8-bit binary counter which counts to 1111 1111, or 255, before resetting to 0000 0000.

Both counters in a package are preset by means of a high level on the Preset (P) input. (The Preset input overrides all synchronous inputs: Clock, \overline{SEI} , and \overline{UE} .) Information is then loaded into the least significant counter thru inputs D0, D1, D2 and D3, and into the most significant counter thru inputs D0', D1'₂AD2', and D3'.

The Up/Down input determines the mode of counting: up when high, down when low.

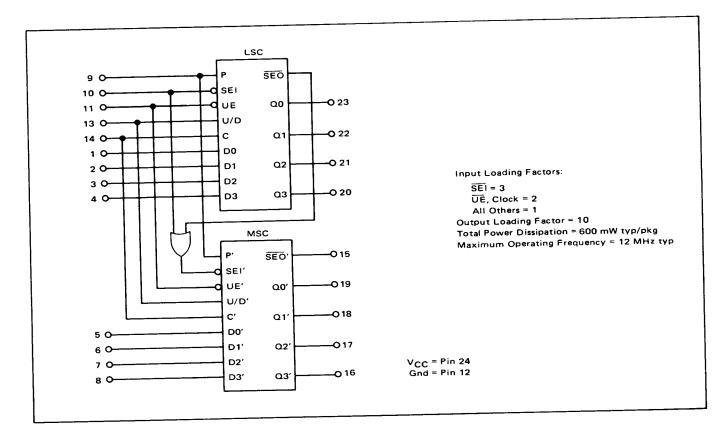
Two Enable inputs are part of these circuits. The Unit Enable (\overline{UE}) affects only the counters within a specific package. The Serial Enable (\overline{SEI}) not only affects a parti-

cular package, but also furnishes a signal at the Serial Enable Output (SEO) for control of succeeding packages in a counter chain. A high input to SEI forces SEO high. When SEI is low, SEO decodes the terminal state of the counter, independently from the UE control, when the counters are in the terminal state. (Terminal state is defined as 0000 0000 when counting down, and as 1111 1111 (256) for the binary counter and 1001 1001 (99) for the decade counter when counting up.)

Both the Serial Enable (SEI) and the Unit Enable (\overline{UE}) must be low for the counter to be clocked. Logic levels on both of these lines must be settled prior to the trailing edge of the Clock, and must remain stable while the Clock is low.

The count state may change only on the leading edge of a Clock pulse. Any changes on the control inputs (Up/Down, SEI, and UE) must be made while the Clock is high.

Counting data is read out on Q0 thru Q3 for the least significant counter, and Q0' thru Q3' for the most significant counter.



											MC43	54/40	54									
							INF	UTS							· · · · ·		(OUTPU	TS	•		
		TENS					UNITS			1	TENS											
COUNT	<u> </u>	UE	SEI	U/D	P	D3'	D2'	D1′	D0'	D3	D2	D1	DO	Q3'	02'	Q1'	00'	03	02	01	00	-
97 98 99 00 00 00 99 98 98 97	104710411044444444444444444444444444444	$\begin{smallmatrix} 1 & 1 & 1 \\ 1 & 1 & 0 \\ 0 & 0 & 0 \\ 0 & 0 & 0 \\ 0 & 0 & 0$	000011110000000000000000000000000000000	$\begin{array}{c} 1 \\ 1 \\ 1 \\ 1 \\ 1 \\ 1 \\ 1 \\ 1 \\ 1 \\ 1 $	100000000000000000000000000000000000000		o x	0 X 0 0 X 0	0 X	0 X	0 X			0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0			0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0		0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1

X = Don't Care

A =

*Outputs count from 12 to 96 during these 84 clock pulses.

**Outputs count from 97 to 13 during these 94 clock pulses.

- 3.0 V - 0 V

MC4355/4055

The MC4355/4055 works in the same manner as the MC4354/4054 except the least significant counter counts to 1111 before clocking the most significant counter, and both counters count to 1111 1111 or 255 before resetting to 0.

MC4356 MC4056

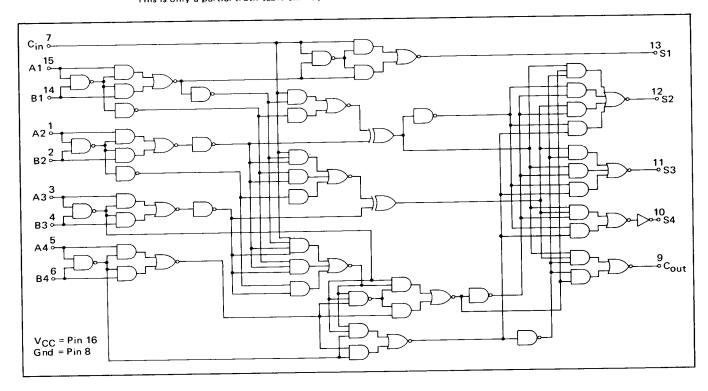
Input Loading Factor: C_{in} = 5 A,B = 2 Output Loading Factor = 10 Total Power Dissipation = 300 mW typ/pkg Propagation Delay Time = 30 ns typ The MC4356/4056 adds two 4-bit numbers in NBCD (Natural Binary Coded Decimal) format. Sum and Carry outputs are generated, also in NBCD code.

NBCD adders are used in such applications as machine controls (to avoid conversion of NBCD data to binary numbers), and in phase-locked loops together with programmable counters. This adder can also subtract, when coupled to a 9's complement logic function.

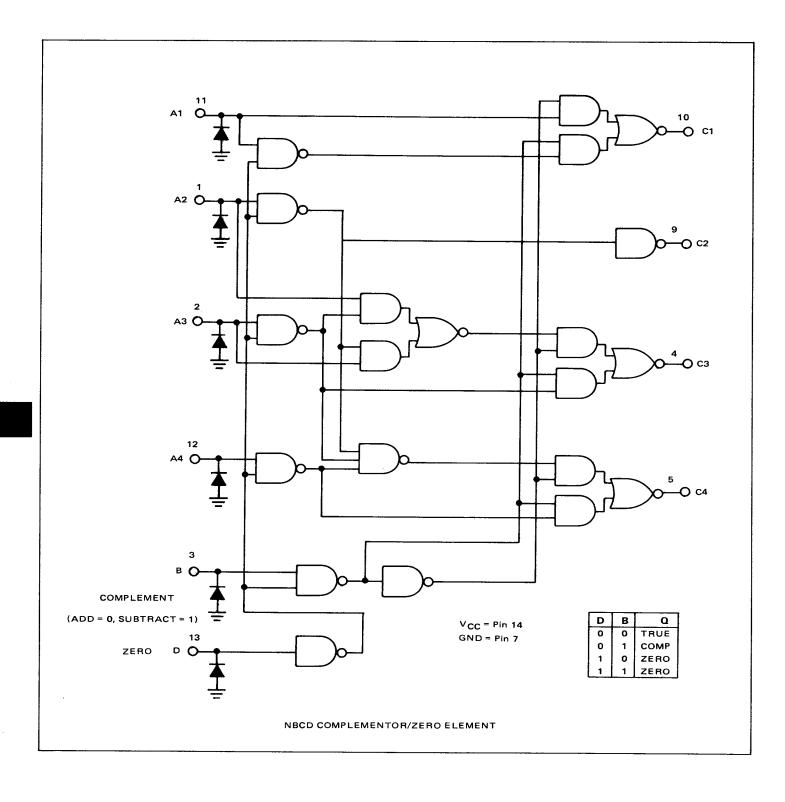
TRUTH TABLE*

				INPUT					OUTPUT						
A4	A3	A2	A1	B4	83	B2	B1	Cin	Cout	S4	S3	S2	S1		
0	0	0	0	0	0	0	0	0	0	0	0	0	0		
o	ō	o	0	0	о	0	0	1	0	0	0	0	1		
ŏ	1	ō	0	0	1	0	0	0	0	1	0	0	0		
o	1	0	0	о	1	0	0	1	0	1	0	0	1		
0	1	1	1	0	1	0	0	0	1	0	0	0	1		
ŏ		1	1	0	1	0	0	1	1	0	0	1	0		
	0	o	1	1	0	0	1	1	1	1	0	0	1		
	ő	0	1	o	0	0	0	1	1	0	0	0	0		
1	o	0	1	ο	0	0	1	0	1	0	0	0	0		

*This is only a partial truth table and is provided to illustrate the logic function of this device.

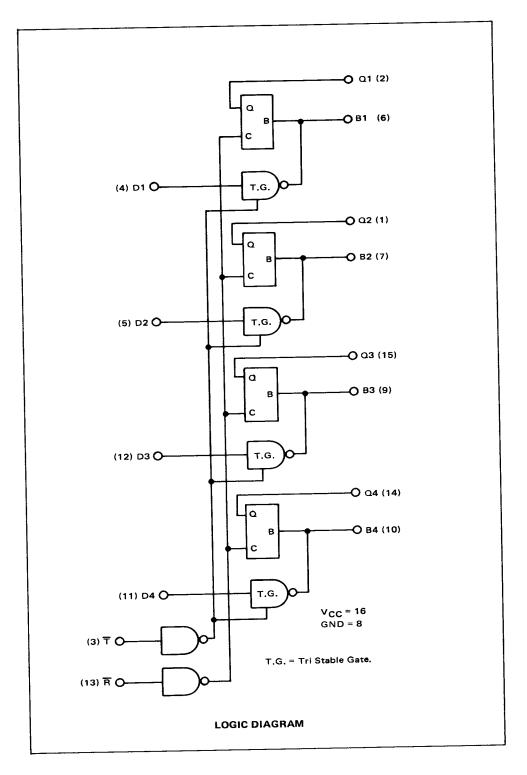


MC4358 MC4058



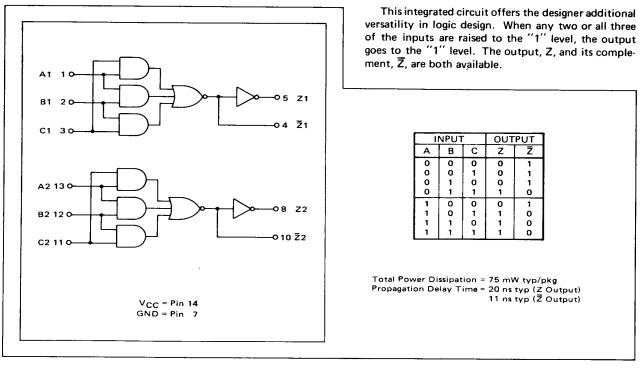
BUS TRANSFER SWITCH

MC4360 MC4060

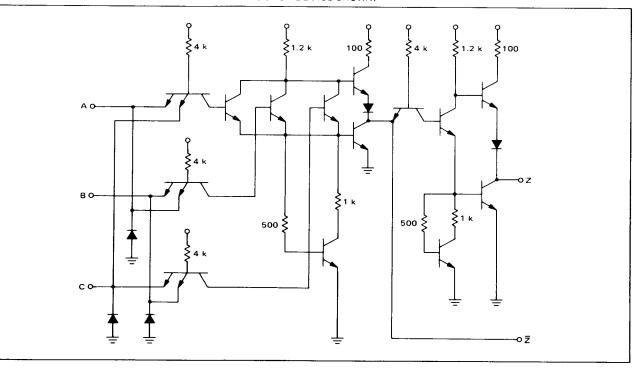


DUAL MAJORITY LOGIC GATE

> MC4362 MC4062



CIRCUIT SCHEMATIC (1/2 OF DEVICE SHOWN)



64-BIT RANDOM ACCESS MEMORY MC4364 MC4064

64-BIT RANDOM ACCESS MEMORY

The MC4364/4064 is a 64-Bit random access memory organized as a 16-word by 4-bit array. Schottky-diode-clamped transistors are utilized to obtain fast switching speeds, and Schottky clamp diodes are used on all inputs to provide minimum line reflection. The high speed of this memory makes it ideal in scratch pad operation.

Address decoding is incorporated in the circuit providing 1-of-16 decoding from the four address lines. Separate Data In and Data Out lines, together with a Chip Enable provide for easy expansion of memory capacity. A Write is provided to enable data presented at the Data In lines to be entered at the addressed storage cells. When writing, Data Out is the complement of the Data In.

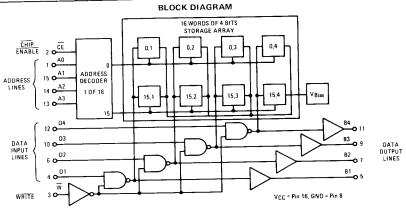
The open-collector output transistors are also Schottky barrier devices and combine greater current sinking capability with lower leakage currents, thereby increasing the wire-OR capability of these devices.

- Both Minimum and Maximum Access Times Specified
- Binary Addressing
- Chip Enable for Memory Expansion
- Outputs May Be "Wire ORed"
- Logic Levels Compatible with MDTL and All MTTL Families
- Low-Voltage Input Clamp Diodes
- Access Time < 60 ns
- Power Dissipation Typically 6 mW/bit
- Outputs Sink 15 mA

MAXIMUM RATINGS

ì

Rating	Symbol	Value	Unit
Supply Voltage	Vcc	7.0	Vdc
Input Voltage – All Inputs	Vin	5.5	Vdc
Output Voltage – All Outputs	VD	5.5	Vdc
Output Current	1D	100	mAdc
Operating Temperature Range – MCM4364L – MCM4064L	TA	-55 to +125 0 to +85	°c
Thermal Resistance, Junction to Ambient (Typical)	θ ја	110	°C/W
Thermal Resistance, Junction to Case (Typical)	θJC	60	°C/W
Storage Temperature Range	T _{stg}	-65 to +160	°ć



PIN ASSIGNMENT

A0

ĒĒ

W

D1

B1

D2

B2

GND

D

0

1

х

x

X = Don't Care

TRUTH TABLE

CE

×

x

0

1

6 🖸

7 (

8 **C**

W

0

0

1

116

15

14

113

112

111

110

] 9

Vcc

A1

A2

Α3

D4

B4

D3

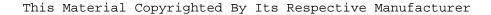
B3

DATA OUT

1

0

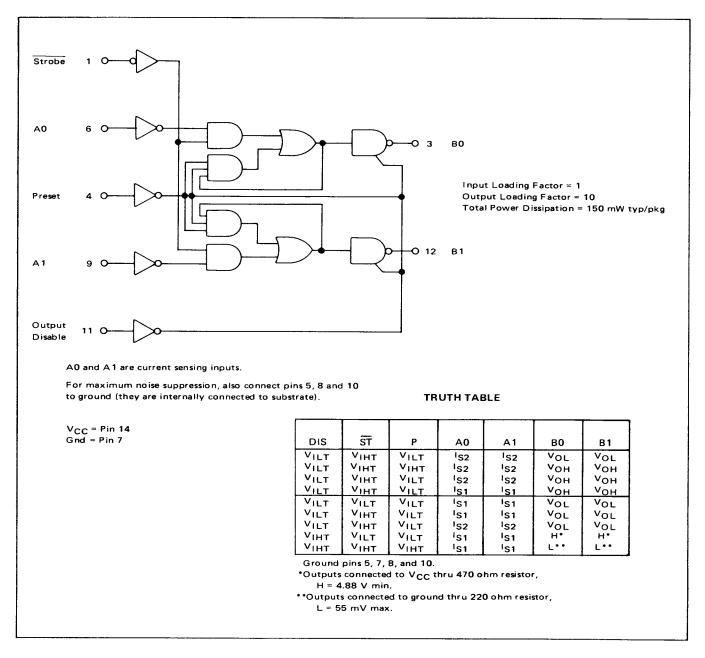
Read

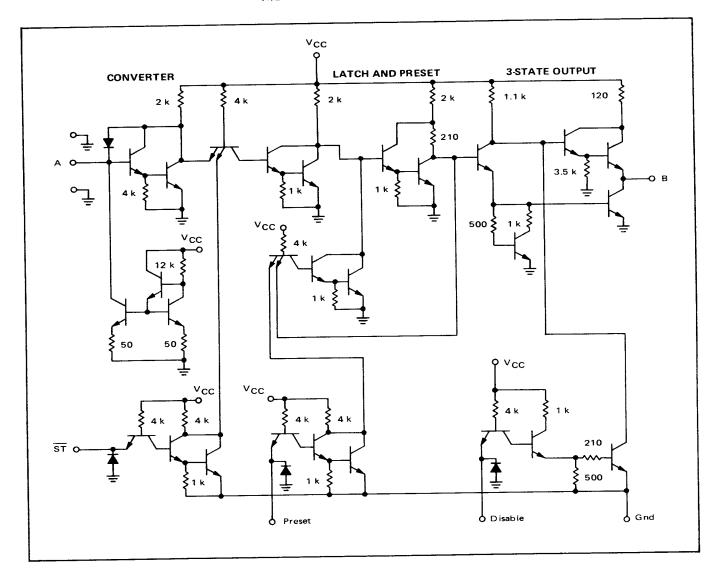


DUAL MOS-TO-TTL LEVEL TRANSLATOR WITH THREE-STATE OUTPUT

MC4368 MC4068

The MC4368/4068 is a dual MOS-to-TTL translator designed to sense the open-drain output current of MOS memories such as the 1103 type. The device has several features that greatly enhance system performance and reduce package count: (1) no external components are required for interfacing, (2) current rather than voltage is sensed, (3) latch capabilities are available, (4) the device has bus driver capabilities, (5) the three-state output feature allows a number of outputs to be tied together on a common data bus without sacrificing the speed of the totem pole output, and (6) only the standard TTL 5-volt power supply is required.





CIRCUIT SCHEMATIC (1/2 of Device and Common Inputs Shown)

OPERATING CHARACTERISTICS

The MC4368/4068 is divided into three basic functions: (1) conversion of the MOS cell current to TTL voltage levels, (2) latching, and (3) coupling to the data bus.

The converter uses a darlington with negative feedback which provides a low input impedance and a fast recovery of the cell data line from noise. A fixed current logic threshold is provided by a sense amplifier arrangement. This threshold is nominally equal to one half of the minimum cell output current and is relatively unaffected by changes in temperature and power supply voltage. Ground pins are provided on each side of the current inputs. These effectively isolate the sensitive inputs from transients.

The latch contains two darlington NANDs which are ORed into another darlington. One NAND is used to strobe the converted MOS cell output into the latch and the other provides feedback for the latch and the preset function.

The latch is then coupled to the output data bus via a three-state output, which allows a number of these outputs to be tied together on a common data bus without sacrificing the speed of the totern pole output.